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9	COLORS
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27	INTENSITIES
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32	POWER
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34	RATE
35	RATES
36	SAMPLE
37	SAMPLED
38	SAMPLEDS
39	SAMPLER
40	SAMPLERS
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42	304672							
43	5584							
44	2737782							
45	479213							
46	125							

	ם	-	Document ID	Issue Date	Pages	Title	Current OR
			US 20050035346 A1	20050217	16	Plasmon assisted enhancement of organic optoelectronic devices	257/40
7	×		US 20050011611 A1	20050120	27	Wafer probe for measuring plasma and surface characteristics in plasma processing environments	156/345.24
	×		US 20040252586 A1	20041216	. 82	Measurement of air characteristics in the lower atmosphere	367/89
4	×		US 20040223135 A1	20041111	75	Methods of calibrating an imaging system using calibration beads	356/28
LC)	×		US 20040213351 A1	20041028	103	Method and apparatus for transmitting signals having a carrier-interferometry architecture	375/260
9	×		US 20040183530 A1	20040923	48	System and method for characterizing a sample by low-frequency spectra	324/248
^	×		US 20040182697 A1	20040923	28	ARC detection approach	204/298.08
8	×		US 20040130702 A1	20040708	71	Lidar system and method	356/5.01
6	×		US 20040087865 A1	20040506	17	Non-invasive health monitor	802/009
10	_×		US 20040077090 A1	20040422	379	Whole cell engineering by mutagenizing a substantial portion of a starting genome, combining mutations, and optionally repeating	435/471
11	×		US 20040076390 A1	20040422	41	Method and apparatus for high resolution coherent optical imaging	385/116
12	×		US 20040020279 A1	20040205	42	Method and apparatus for the actuation of the cantilever of a probe-based instrument	73/105
13	×		US 20040012600 A1	20040122	72	Scalable high performance 3d graphics	345/506
14	×		US 20030227619 A1	20031211	19	Optical scanning system for surface inspection	356/237.2
15	×		US 20030206294 A1	20031106	19	Optical scanning system for surface inspection	356/237.2
16	×_		US 20030205460 A1	20031106	29	Apparatus and method for arc detection	204/192.13
17	×		US 20030169847 A1	20030911	101	System and method for x-ray fluoroscopic imaging	378/98.3
18	×		US 20030160212 A1	20030828	27	New family of conducting liquid crystals	252/299.62

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-	438/82	•	Bazan, Guillermo C. et al.	_×						US 20050035346	
7			Mahoney, Leonard J. et al.							US 20050011611	
თ			Martin, Andrew Louis							US 20040252586	
4	356/28.5		Ortyn, William E. et al.							US 20040223135	
N.			Shattil, Steve J.							US 20040213351	
9	324/247		Butters, Bennett M. et al.							US 20040183530	
_	204/298.03; 204/298.06		Buda, Paul R.							US 20040182697	
æ	•		Jupp, David L et al.							US 20040130702	
6			Kelly, Craig A.							US 20040087865	
10	435/252.3; 435/254.2		Short, Jay M.							US 20040077090	
11	385/117		Dong Yang, Victor Xiao et al.						-	US 20040076390	
12	702/87; 73/866.5		Degertekin, F. Levent et al.							US 20040020279	
13	345/519; 345/545		Deering, Michael F. et al.							US 20040012600	
14			Leslie, Brian C. et al.							US 20030227619	
15			Leslie, Brian C. et al.							US 20030206294	
16	204/192.12; 204/298.03; 204/298.06; 204/298.08		Buda, Paul R.							US 20030205460	
17			Karellas, Andrew et al.							US 20030169847	
18	428/1.1		Boden, Neville et al.							US 20030160212	

	Current XRef	Retrieval Classif	Inventor	S	ပ	d	2	6	4	2	Image Doc. Displayed	PT
19	356/28.5		Ortyn, William E. et al.							_ر_	US 20030142289	
20			LaDue, Christoph								US 20030133423	
21			Fala, Joseph M. et al.								US 20030048500	
22		,	Vander Jagt, Peter G. et al.								US 20030048449	
23	73/105		Degertekin, F. Levent et al.								US 20030041669	
24			Degertekin, F. Levent								US 20030041657	
25	369/112.24; 369/52.1; 369/53.22		Worthington, Mark Oscar							ر_	US 20030035352	
26	96/209		Handy, Erik S. et al.									
27			Worthington, Mark Oscar et al.									
28			Gillispie, Gregory									
59	369/59.11		Powelson, Judith C. et al.									
30			Riley, James K. et al.									
31			Velazquez, Scott R.									
32			Ortyn, William E. et al.	·.· ·		•						
33			Shattil, Steve J.									
34	426/581; 426/601; 426/602		Arends, Berend Jan et al.									

	n	1	Document:ID	Issue Date	Pages	Title	Current OR
35	×		US 20010033238 A1	20011025		Linearity error compensator	341/118
36	×		US 6888633 B2	20050503		Color measurement instrument with modulated illumination	356/407
37	×		US 6888627 B2	20050503		Optical scanning system for surface inspection	356/237.2
38	×		US 6879817 B1	20050412		DC offset, re-radiation, and I/Q solutions using universal frequency translation technology	455/296
39	×		US 6873836 B1	20050329		Universal platform module and methods and apparatuses relating thereto enabled by universal frequency translation technology	455/313
40	×		US 6836650 B2	20041228		Methods and systems for down-converting electromagnetic signals, and applications thereof	455/319
41	×		US 6813485 B2	20041102		Method and system for down-converting and up- converting an electromagnetic signal, and transforms for same	455/313
42	×		US 6798351 B1	20040928		Automated meter reader applications of universal frequency translation	340/870.02
43	×		US 6779387 B2	20040824		Method and apparatus for the ultrasonic actuation of the cantilever of a probe-based instrument	73/105
44	×		US 6778263 B2	20040817		Methods of calibrating an imaging system using calibration beads	356/28
45	_×	_	US 6736944 B2	20040518		Apparatus and method for arc detection	204/192.13
46	×		US 6704558 B1	20040309		Image-reject down-converter and embodiments thereof, such as the family radio service	455/323
47	×		US 6704549 B1	20040309		Multi-mode, multi-band communication system	455/102
48	_×_		US 6694817 B2	20040224		Method and apparatus for the ultrasonic actuation of the cantilever of a probe-based instrument	73/661

	Current XRef	Retrieval Classif	Inventor	S	υ	۵	7	m	4	2	Image Doc. Displayed	F
35			Velazquez, Scott R.									
36	250/226		Vander Jagt; Peter G. et al.		-							
37			Leslie; Brian C. et al.									
38	455/207; 455/209; 455/313; 455/323		Sorrells; David F. et al.									
39	455/113; 455/323; 455/76		Sorrells; David F. et al.									
40	455/323; 455/337		Sorrells; David F. et al.									
41	455/118; 455/323		Sorrells; David F. et al.									
42	455/18		Sorrells; David F. et al.									
43			Degertekin; F. Levent									
44	356/28.5		Ortyn; William E. et al.									
45	204/192.33; 204/298.03		Buda; Paul R.									
46	375/349; 455/285; 455/302		Sorrells; David F. et al.									
47			Sorrells; David F. et al.									
48	73/105; 73/652		Degertekin; F. Levent et al.									

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49	327/105; 331/143; 331/34; 376/376; 455/260		Sorrells; David F. et al.		•							
20	252/299.01; 252/299.61; 252/299.62; 532/1; 544/343; 568/632; 585/26		Boden; Neville et al.									
51	455/313; 455/333		Sorrells; David F. et al.									
52			Shattil; Steve J.									
53	455/61		Bultman; Michael J. et al.									
54	426/239; 426/495; 426/524; 426/601		Arends; Berend Jan et al.									
55	329/362; 329/369; 455/313		Sorrells; David F. et al.									
26	345/440.1		Gauland; Michael A. et al.						·			
57	341/120		Velazquez; Scott R.									
. 85	375/328; 375/351		Cook; Robert W. et al.									

	Current XRef	Retrieval Classif	Inventor	S	U	a.	2 3	4	S	Image Doc. Displayed	F
29	375/219; 455/113; 455/83		Sorrells; David F. et al.								
09	356/28.5; 356/39		Ortyn; William E. et al.								
61	702/42		Radomski; James V.								
62	356/28.5; 356/39		Riley; James K. et al.								
63	381/84; 381/94.1		Jackson; Douglas L.								
64	348/445; 348/446; 348/458; 348/556		Stapleton; John J.								
92			Krahn; John Raymond et al.								
99	341/120	,	Velazquez; Scott R.								
	455/323; 455/333		Cook; Robert W. et al.								
89	250/584; 250/585; 250/586; 250/591; 356/417; 359/216		Basiji; David A. et al.						·		
69	327/113; 455/313		Sorrells; David F. et al.								
70	455/115.1		Sorrells; David F. et al.								
71	341/120		Velazquez; Scott R.				-				
72	455/113		Sorrells; David F. et al.					•			

	Current XRef	Retrieval Classif	Inventor	S	U	۵	7	ю	4	5	Image Doc. Displayed	P
110	702/17; 708/307; 708/422		Hyatt; Gilbert P.									
111			Hyatt; Gilbert P.			·						
112	708/423		Hyatt; Gilbert P.									
113			Hyatt; Gilbert P.									
114	386/125; 386/94		Knight; Howard W. et al.					-				
115	356/432		Patel; Chandra K. N. et al.									
116	360/22; 360/63; 360/78.04; 386/92	·	Diermann; Joachim P. et al.									
117	600/447; 600/455; 73/602; 73/861.25	,	Papadofrangakis; Emmanuel et al.	•			, , , , , , , , , , , ,					
118			Hyatt; Gilbert P.									
119	244/3.16; 250/203.1; 250/332; 250/342; 250/347; 250/349; 356/141.4;		Watkins; Robert A.									
120	600/441; 600/455; 73/641		Papadofrangakis; Emmanuel et al.									
121			Gallo; Luigi C.					-				
122	2/19		Green; Philip S. et al.									

ر 	1	Document ID	Issue Date	Pages	Title	Current OR
×	-	US 3896266 A	19750722		Credit and other security cards and card utilization systems therefore	379/114.19
×		US 3515981 A	19700602		SUPER-REGENERATIVE RESONANCE SPECTROMETERS	324/310
×		US 3475680 A	19691028		IMPULSE RESONANCE SPECTROMETER INCLUDING A TIME AVERAGING COMPUTER AND FOURIER AND YZED	324/312

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123	379/91.01; 379/93.03; 902/22; 902/23; 902/3		Waterbury; Nelson J.									
124			TONG DAVID ARTHUR et al.									
125	125 250/292		ANDERSON WESTON A et al.									



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